Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/675,900	BUCHANAN ET AL	
Examiner	Art Unit	
Leigh C. Maier	1623	

SEARCHED					
Class	Subclass	Date	Examiner		
424	468 486 488 449	7/14/2006	LCM		
514	58	7/14/2006	LCM		
623	1.42	7/14/2006	LCM		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
-EAST (transcript attached)	7/14/2006	LCM		